

Description

Silicon Carbide (SiC) MOSFET use a completely new technology that provide superior switching performance and higher reliability compared to Silicon. In addition, the low ON resistance and compact chip size ensure low capacitance and gate charge. Consequently, system benefits include highest efficiency, faster operating frequency, increased power density, reduced EMI, and reduced system size.

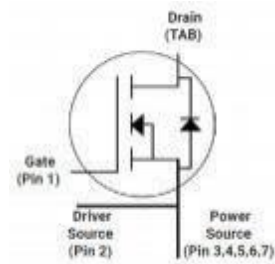
Features

- High Speed Switching with Low Capacitances
- High Blocking Voltage with Low RDS(on)
- Low parasitic inductance and Low impedance package
- Separate driver source pin
- Normally-off and simple to drive
- ROHS Compliant, Halogen free



Application

- High-frequency applications
- High-voltage capacitive loads
- Switch Mode Power Supplies
- Auxiliay power supplies



Ordering Information

Part Number	Marking	Package	Packaging
JX7S0750R170T3	JX7S0750R170T3	TO-263-7	Tube

Absolute Maximum Ratings(Tc=25°C)

Symbol	Parameter	Value	Unit
V _{DS}	Drain-Source Voltage	1700	V
I _D	Drain Current(continuous)at Tc=25°C	5	A
I _D	Drain Current(continuous)at Tc= 100°C	3	A
I _{DM}	Drain Current (pulsed)	10	A
V _{GS}	Gate-Source Voltage	-5/+15	V
P _D	Power Dissipation Tc = 25°C	60	W
T _J , T _{stg}	Junction and Storage Temperature Range	-55 to +150	°C

Electrical Characteristics(T_J = 25°C unless otherwise specific d)
Typical Performance-Static

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
BV _{DS}	Drain-source Breakdown Voltage	I _D =250uA, V _{GS} =0V	1700			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 1700V, V _{GS} =0V, T _J =25°C			100	uA
I _{GSS}	Gate-body Leakage Current	V _{DS} =0V ; V _{GS} =-5 to 15V			250	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 1mA	1.5	2	3	V
V _{GSon}	Recommended turn-on Voltage	Static		12		V
V _{GSoff}	Recommended turn-off Voltage			-3		V
R _{DS(on)}	Static Drain-source On Resistance	V _{GS} = 12V, I _D =2A		750	1000	mΩ
		V _{GS} = 12V, I _D =2A T _J = 150°C		1220		mΩ

Typical Performance-Dynamic

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
C _{iss}	Input Capacitance	V _{DS} =1000V, f=1MHz , V _{AC} =25mV		200		pF
C _{oss}	Output Capacitance			12		pF
C _{rss}	Reverse Transfer Capacitance			2		pF
g _{fs}	Transconductance	V _{DS} = 10V , I _b = 1A		0.48		S
E _{OSS}	C _{oss} Stored Energy	V _{DS} = 1000V, f=1MHz		5.8		μJ
E _{ON}	Turn-On Energy (Body Diode)	V _{DS} = 1200V, V _{GS} =-5/12V , I _b =2A , L=1.5mH T _J = 150 °C		53		μJ
E _{OFF}	Turn-Off Energy (Body Diode)			62		μJ
Q _g	Total Gate Charge	V _{DS} = 1200V, V _{GS} =-5V/ 12V, I _b = 2A		11		nC
Q _{gs}	Gate-source Charge			2		nC
Q _{gd}	Gate-Drain Charge			6		nC
R _{G(int)}	Internal Gate Resistance	f=1MHz, V _{AC} =25mV		28		Ω
t _{d(on)}	Turn-on Delay Time	V _{DS} = 1200V, V _{GS} =-5V/12V, I _b =2A, L= 1.5mH R _{ext} =2.5Ω		6		ns
t _r	Rise Time			10		ns
t _{d(off)}	Turn-off Delay Time			19		ns
t _f	Fall Time			56		ns

Typical Performance-Reverse Diode(T_J = 25°C unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V _{FSD}	Forward Voltage	V _{GS} =0V, I _F =1A, T _J =25° C		4.2	6.5	V
		V _{GS} =0V, I _F =1A, T _J =150° C		3.9	6	V
I _S	Continuous Diode Forward Current	V _{GS} =0V , T _C =25° C			5	A

Thermal Characteristics

Symbol	Parameter	Value.	Unit
R _{θJC}	Thermal Resistance, Junction-to-Case	2.5	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient	40	°C/W

The values are based on the junction-to case thermal impedance which is measured with the device mounted to a large heat sink assuming maximum junction temperature of T_J(max)= 150° C

Electrical Characteristics

Fig1. Output characteristics ($T_J = 25^\circ\text{C}$)

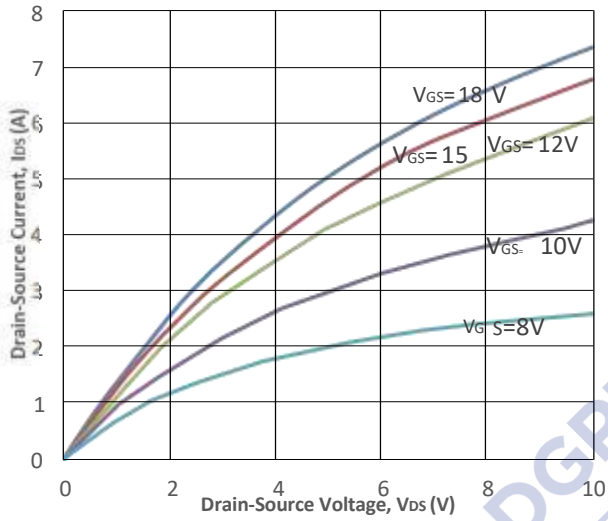


Fig2. Output characteristics ($T_J = 150^\circ\text{C}$)

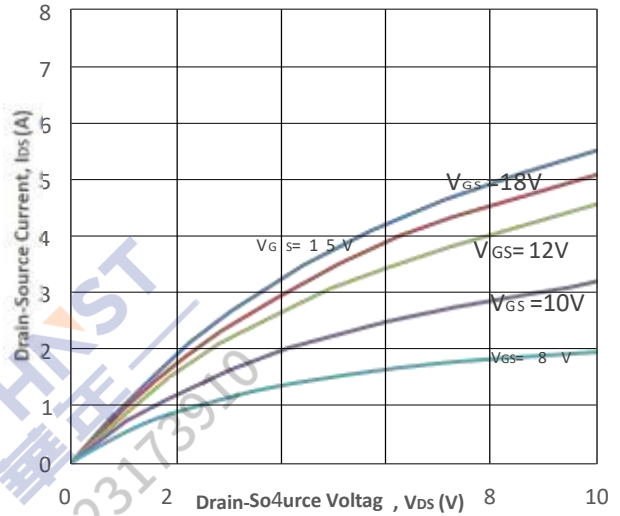


Fig3. Normalized On-Resistance vs. Temperature

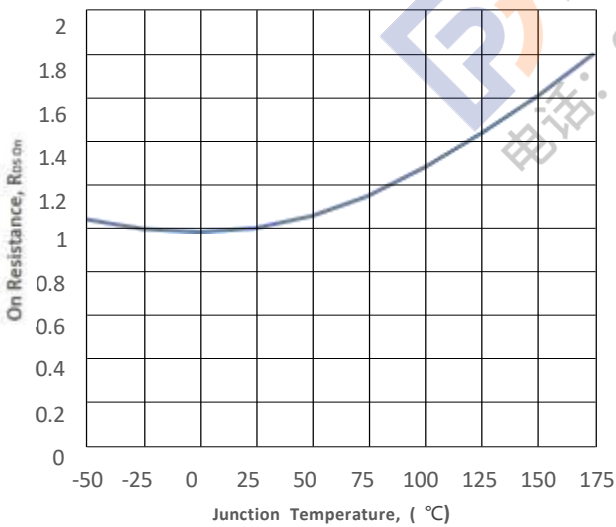


Fig4. On-Resistance vs. Temperature

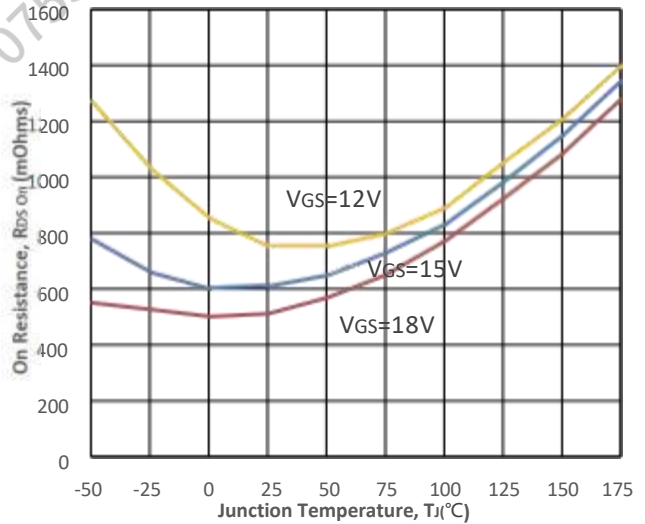


Fig5. Transfer Characteristic

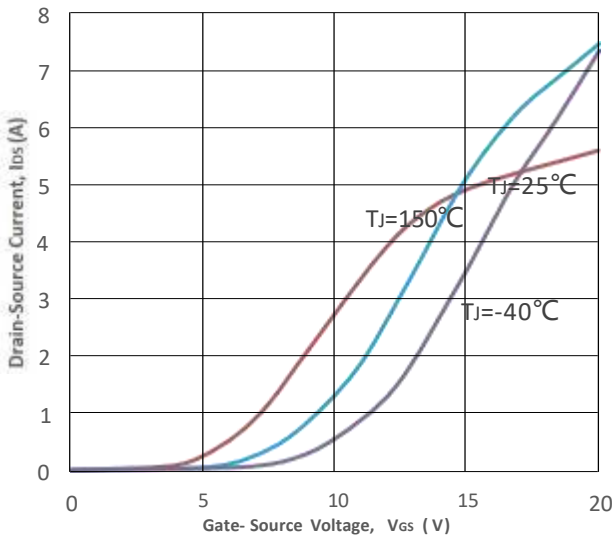


Fig6. Body Diode Characteristic at 25°C

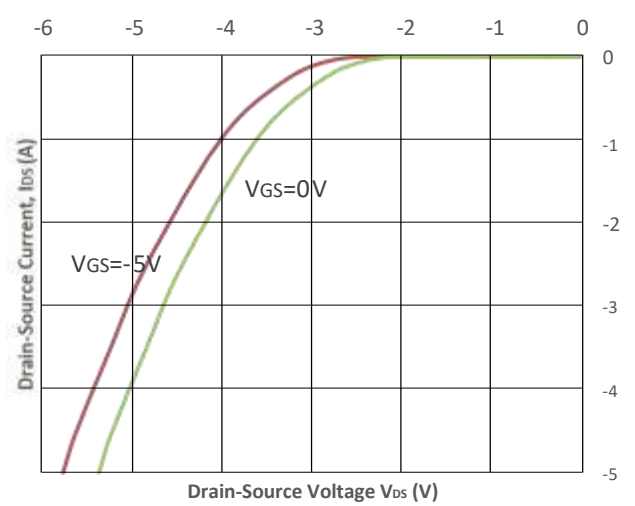


Fig7. Threshold Voltage vs. Temperature

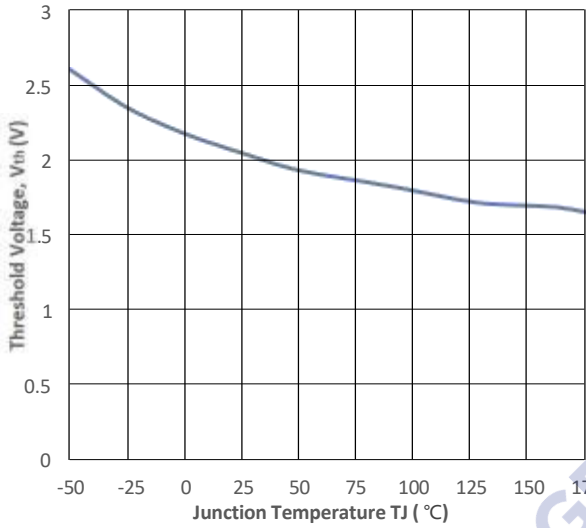


Fig8. Gate Charge Characteristics

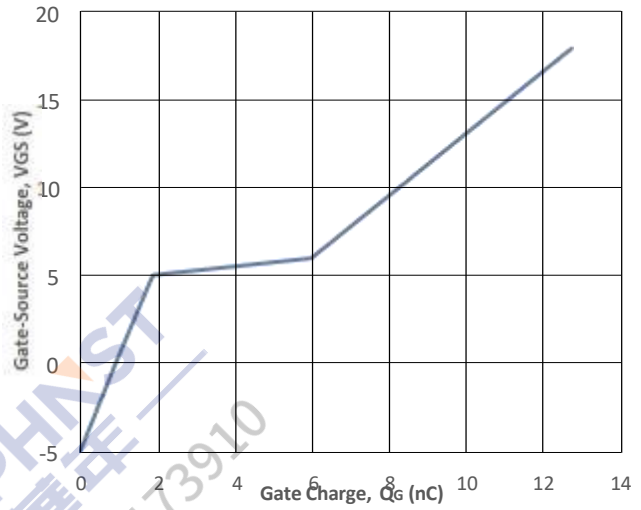


Fig9. 3rd Quadrant Characteristic at 25°C

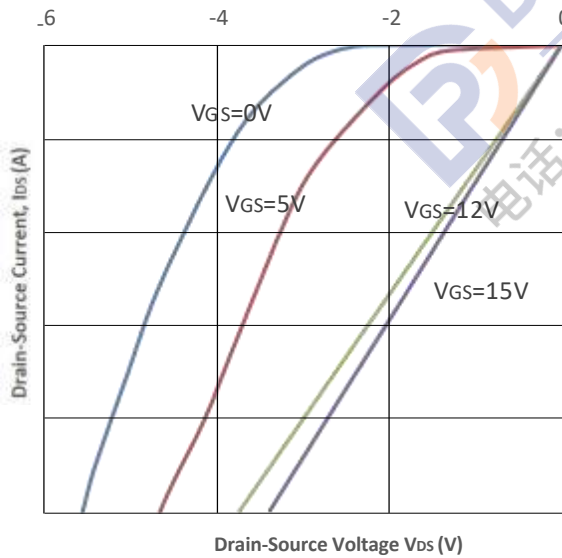


Fig10. Output Capacitor Stored Energy

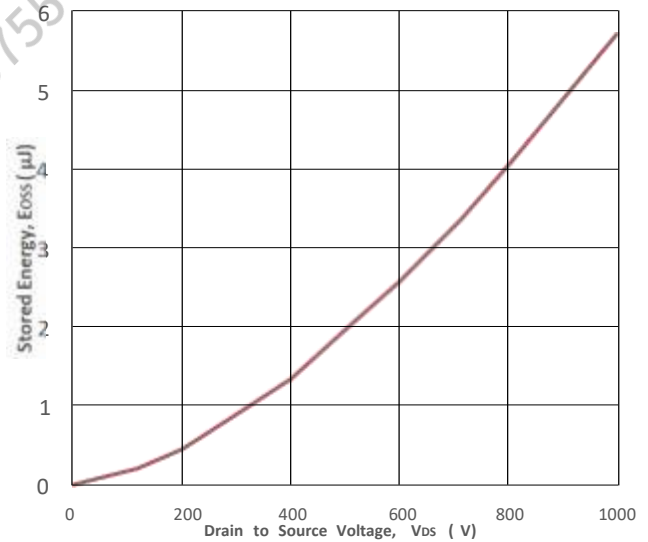


Fig11. Capacitances vs. Drain-Source

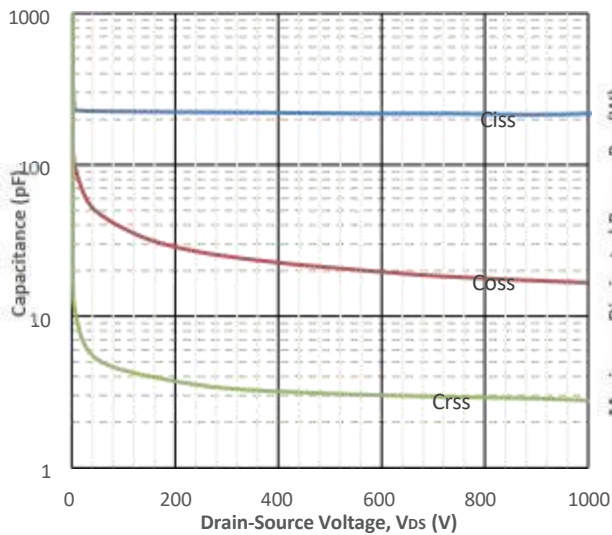


Fig12. Max Power Dissipation Derating Vs T_c

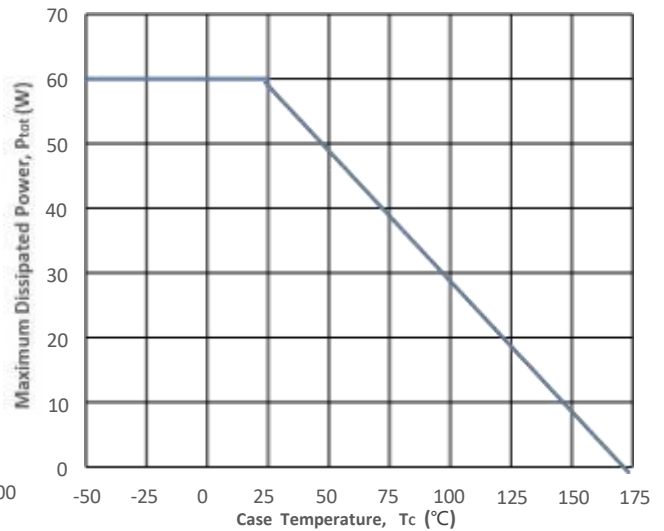


Fig13. Switching Energy vs. Drain Current

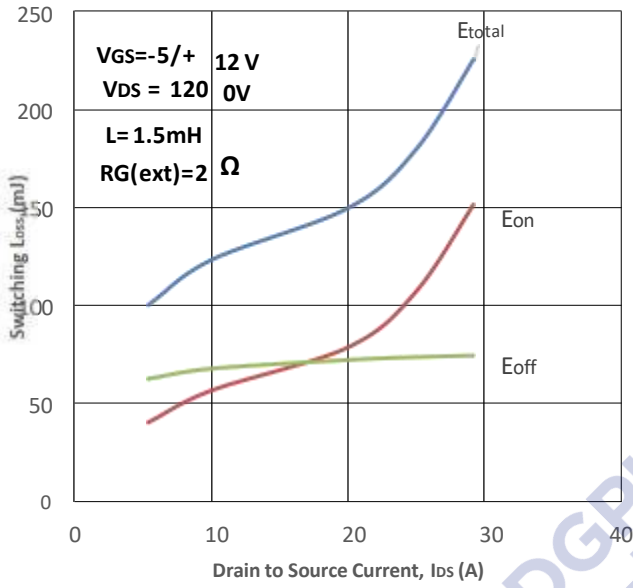


Fig14. Switching Energy vs. $R_{G(ext)}$

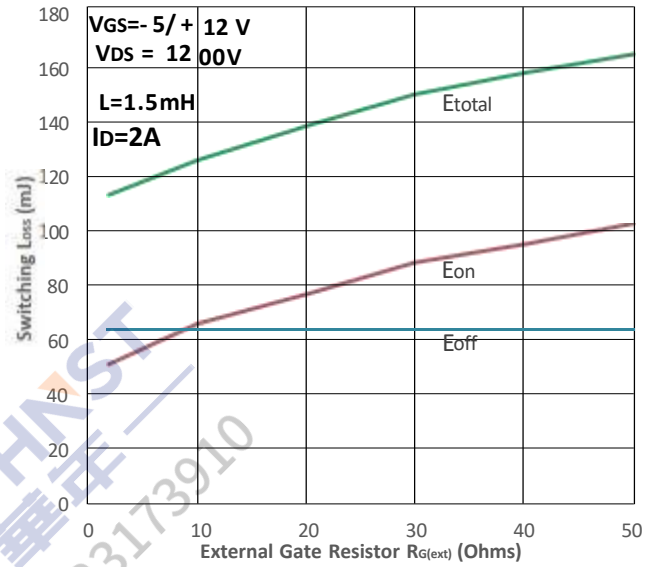


Fig15. Transient Thermal Impedance

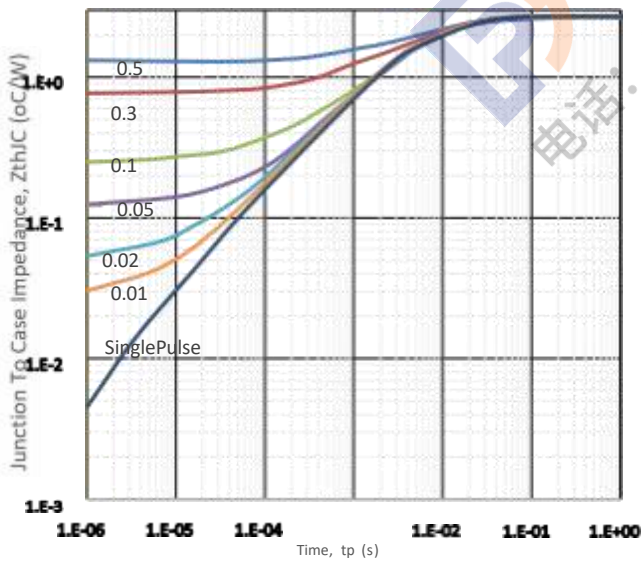
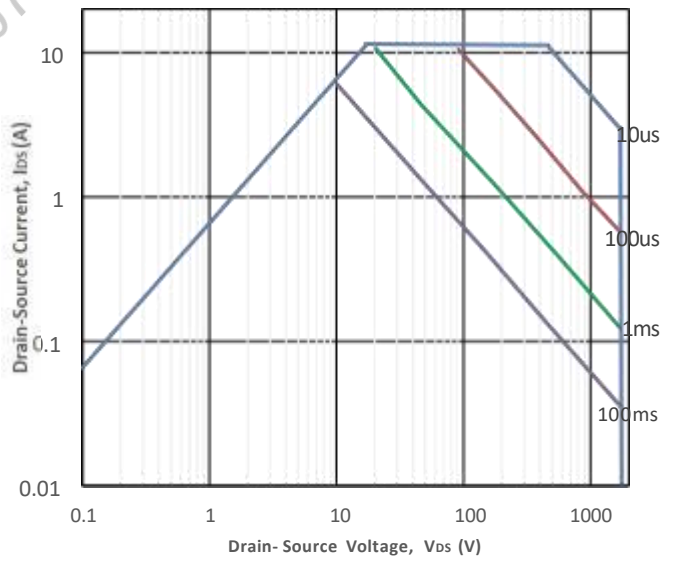
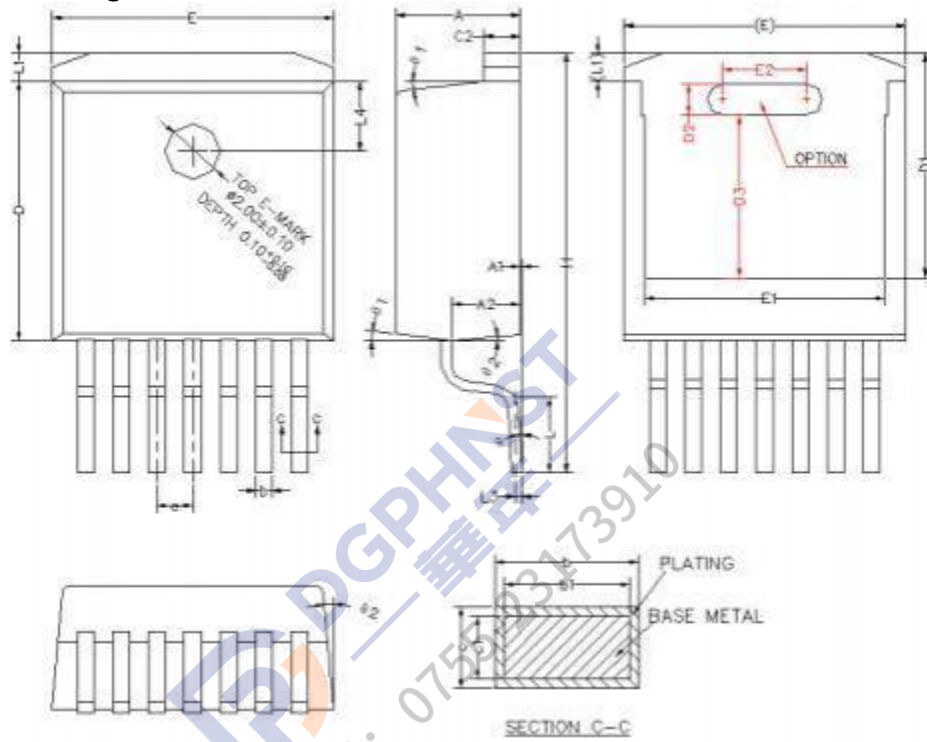


Fig16. Safe Operating Area



Package Drawing:



Dimensions (UNIT: mm)

SYMBO	MIN	NOM	MAX
A	4.30	4.40	4.50
A1	0.00	0.10	0.25
A2	2.30	2.40	2.50
b	0.56	-	0.69
b1	0.55	0.60	0.65
c	0.37	-	0.44
c1	0.36	0.38	0.40
c2	1.22	1.27	1.32
D	9.15	9.25	9.35
D1	7.90	8.00	8.10
D2	1.00	1.11	1.20
D3	5.70	5.80	5.90
E	9.90	10.00	10.10
E1	8.40	8.50	8.60
E2	2.90	3.00	3.10
e	1.17	1.27	1.37
H	14.60	14.95	15.35
L	2.40	2.70	2.90
L1	0.90	1.00	1.10
L3		0.25BSC	
L4		2.50REF	
θ	0°		8°
θ1	5°	7°	9°
θ2	3°	5°	7°